


<b>Search Notes</b>  	<b>Application/Control No.</b>  10808971	<b>Applicant(s)/Patent Under Reexamination</b>  TEN EYCK ET AL.
	<b>Examiner</b>  John P Lacyk	<b>Art Unit</b>  3735

SEARCHED			
Class	Subclass	Date	Examiner
600	21-22, 300-301, 523	6/10/07	JPL
705	3	6/10/07	JPL
340	573.1, 691.6	6/10/07	JPL
Updated	above	1/17/08	JPL
Updated	above	7/03/08	JPL

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner